



The Jointed Test Finger is a precision test probe made according to Figure 2 (Fig. 2) of the IEC 61032 (Test probe B) and is used to simulate a human finger. It is also used by the standards of CSA, IRAM, UL and IEC 60529 in most of the rules involved in the verification of accessibility to live parts.

Technical Parameters:

1. Knurled Finger Diameter: 12 mm
2. Knurled Finger Length: 80 mm
3. Baffle Plate Diameter: 50 mm
4. Baffle Plate Length: 100 mm
5. Baffle thickness: 20 mm
6. Thrust: 10N

